

PM25RLA120

FLAT-BASE TYPE
INSULATED PACKAGE

PM25RLA120



FEATURE

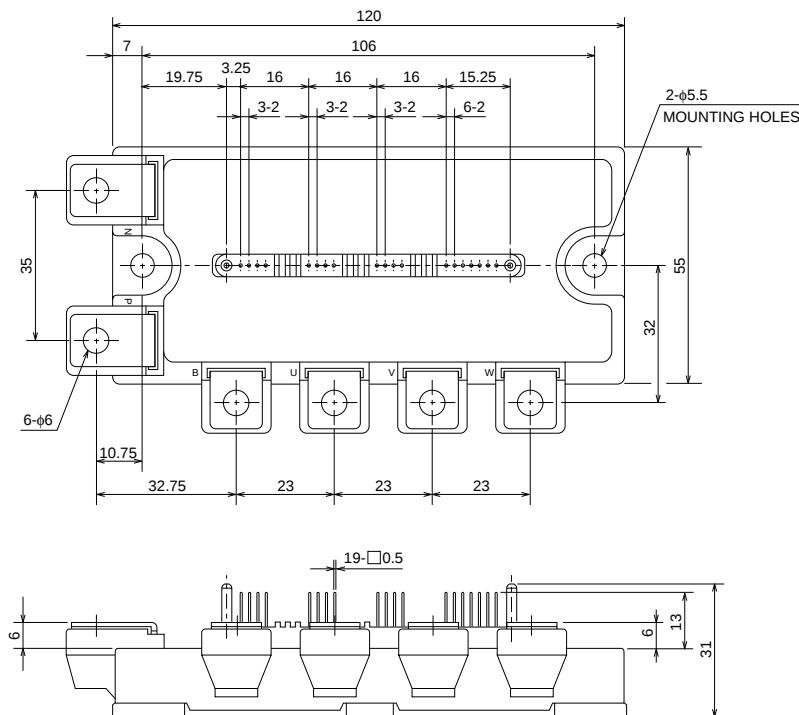
- a) Adopting new 5th generation IGBT (CSTBT) chip, which performance is improved by 1 μ m fine rule process.
For example, typical $V_{ce(sat)}$ =1.9V @Tj=125°C
- b) I adopt the over-temperature conservation by Tj detection of CSTBT chip, and error output is possible from all each conservation upper and lower arm of IPM.
- c) Current rating of brake part increased.
60% for the current rating of inverter part.
 - 3 ϕ 25A, 1200V Current-sense IGBT type inverter
 - 15A, 1200V Current-sense regenerative brake IGBT
 - Monolithic gate drive & protection logic
 - Detection, protection & status indication circuits for, short-circuit, over-temperature & under-voltage (P-Fo available from upper arm devices)
 - Acoustic noise-less 3.7kW class inverter application

APPLICATION

General purpose inverter, servo drives and other motor controls

PACKAGE OUTLINES

Dimensions in mm

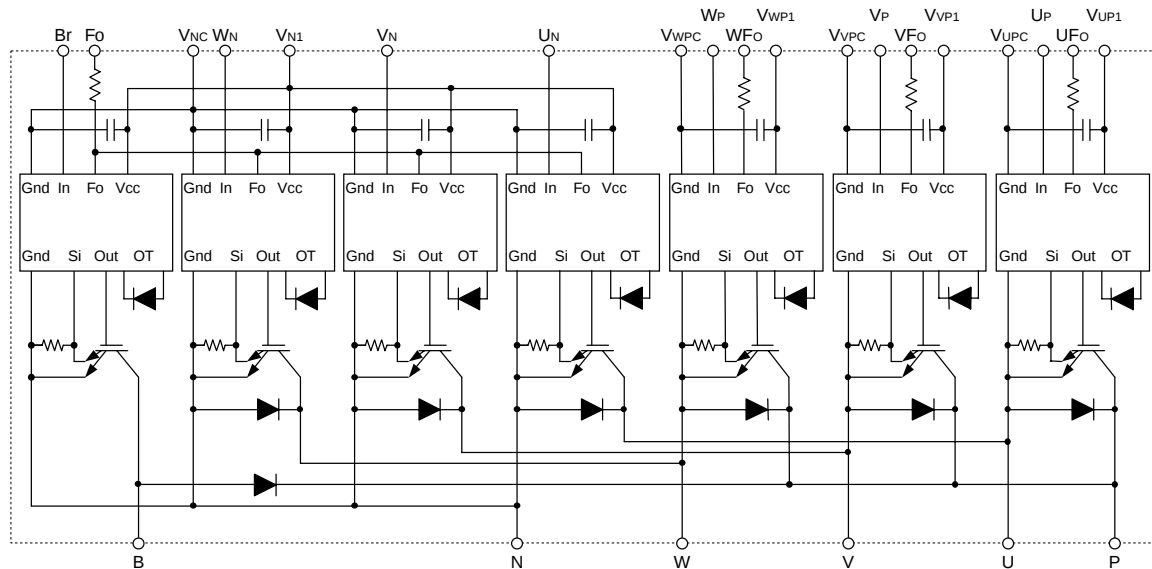


Terminal code

- | | |
|---------|----------|
| 1. VUPC | 11. WP |
| 2. UFO | 12. VWP1 |
| 3. UP | 13. VNC |
| 4. VUP1 | 14. VN1 |
| 5. VVPC | 15. Br |
| 6. VFO | 16. UN |
| 7. VP | 17. VN |
| 8. VVP1 | 18. WN |
| 9. VWPC | 19. Fo |
| 10. WFO | |

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INTERNAL FUNCTIONS BLOCK DIAGRAM**MAXIMUM RATINGS** ($T_j = 25^\circ\text{C}$, unless otherwise noted)**INVERTER PART**

Symbol	Parameter	Condition	Ratings	Unit
V_{CES}	Collector-Emitter Voltage	$V_D = 15\text{V}$, $V_{CIN} = 15\text{V}$	1200	V
$\pm I_C$	Collector Current	$T_c = 25^\circ\text{C}$	25	A
$\pm I_{CP}$	Collector Current (Peak)	$T_c = 25^\circ\text{C}$	50	A
P_C	Collector Dissipation	$T_c = 25^\circ\text{C}$ (Note-2)	116	W
T_j	Junction Temperature		$-20 \sim +150$	$^\circ\text{C}$

BRAKE PART

Symbol	Parameter	Condition	Ratings	Unit
V_{CES}	Collector-Emitter Voltage	$V_D = 15\text{V}$, $V_{CIN} = 15\text{V}$	1200	V
I_C	Collector Current	$T_c = 25^\circ\text{C}$	15	A
I_{CP}	Collector Current (Peak)	$T_c = 25^\circ\text{C}$	30	A
P_C	Collector Dissipation	$T_c = 25^\circ\text{C}$ (Note-2)	100	W
$V_{R(DC)}$	FWDi Rated DC Reverse Voltage	$T_c = 25^\circ\text{C}$	1200	V
I_F	FWDi Forward Current	$T_c = 25^\circ\text{C}$	15	A
T_j	Junction Temperature		$-20 \sim +150$	$^\circ\text{C}$

CONTROL PART

Symbol	Parameter	Condition	Ratings	Unit
V_D	Supply Voltage	Applied between : $V_{UP1}-V_{UPC}$ $V_{VP1}-V_{VPC}$, $V_{WP1}-V_{WPC}$, $V_{N1}-V_{NC}$	20	V
V_{CIN}	Input Voltage	Applied between : U_P-V_{UPC} , V_P-V_{VPC} W_P-V_{WPC} , $U_N \cdot V_N \cdot W_N \cdot B_r-V_{NC}$	20	V
V_{FO}	Fault Output Supply Voltage	Applied between : $U_{FO}-V_{UPC}$, $V_{FO}-V_{VPC}$, $W_{FO}-V_{WPC}$ F_O-V_{NC}	20	V
I_{FO}	Fault Output Current	Sink current at U_{FO} , V_{FO} , W_{FO} , F_O terminals	20	mA

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TOTAL SYSTEM

Symbol	Parameter	Condition	Ratings	Unit
V _{CC(Prot)}	Supply Voltage Protected by SC	V _D = 13.5 ~ 16.5V, Inverter Part, T _J = +125°C Start	800	V
V _{CC(surge)}	Supply Voltage (Surge)	Applied between : P-N, Surge value	1000	V
T _C	Module Case Operating Temperature	(Note-2)	-20 ~ +100	°C
T _{stg}	Storage Temperature		-40 ~ +125	°C
V _{iso}	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base, AC 1 min.	2500	V _{rms}

THERMAL RESISTANCES

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
R _{th(j-c)Q}	Junction to case Thermal Resistances	Inverter IGBT (per 1 element) (Note-1)	—	—	0.83	°C/W
R _{th(j-c)F}		Inverter FWDi (per 1 element) (Note-1)	—	—	1.36	
R _{th(j-c)Q}		Brake IGBT (Note-1)	—	—	0.96	
R _{th(j-c)F}		Brake FWDi (Note-1)	—	—	1.82	
R _{th(j-c)Q}		Inverter IGBT (per 1 element) (Note-2)	—	—	1.08	
R _{th(j-c)F}		Inverter FWDi (per 1 element) (Note-2)	—	—	1.77	
R _{th(j-c)Q}		Brake IGBT (Note-2)	—	—	1.25	
R _{th(j-c)F}		Brake FWDi (Note-2)	—	—	2.37	
R _{th(c-f)}	Contact Thermal Resistance	Case to fin, (per 1 module) Thermal grease applied	—	—	0.038	

(Note-1) T_C measurement point is just under the chips (Bottom view).

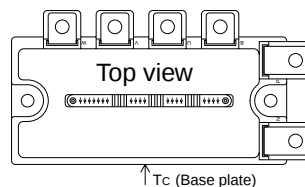
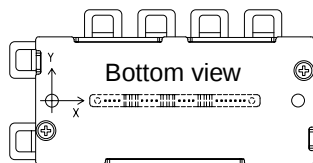
If you use this value, R_{th(f-a)} should be measured just under the chips.

(Note-2) T_C measurement point is as shown below (Top view).

Table1 : T_C measurement point of just under the chips.

(Unit : mm)

axis	arm	UP		VP		WP		UN		VN		WN		Br	
		IGBT	FWDi	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi	IGBT	FWDi
X		29.0	29.3	65.0	65.5	85.6	85.9	37.8	37.5	55.2	55.7	75.8	75.3	19.0	22.3
Y		-7.1	1.5	-7.1	2.0	-7.1	2.0	5.1	-4.5	5.1	-4.5	5.1	-4.5	-7.3	6.6



ELECTRICAL CHARACTERISTICS (T_J = 25°C, unless otherwise noted)

INVERTER PART

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
V _{CE(sat)}	Collector-Emitter Saturation Voltage	V _D = 15V, I _C = 25A V _{CIN} = 0V, Pulsed (Fig. 1)	—	1.8	2.3	V
		T _J = 25°C T _J = 125°C	—	1.9	2.4	
V _{EC}	FWDi Forward Voltage	-I _C = 25A, V _D = 15V, V _{CIN} = 15V (Fig. 2)	—	2.5	3.5	V
t _{on}	Switching Time	V _D = 15V, V _{CIN} = 0V↔15V V _{CC} = 600V, I _C = 25A T _J = 125°C Inductive Load (Fig. 3,4)	0.5	1.0	2.5	μs
t _{rr}			—	0.5	0.8	
t _{c(on)}			—	0.4	1.0	
t _{off}			—	2.0	3.0	
t _{c(off)}			—	0.7	1.2	
I _{CES}	Collector-Emitter Cutoff Current	V _{CE} = V _{CES} , V _{CIN} = 15V (Fig. 5)	—	—	1	mA
		T _J = 25°C T _J = 125°C	—	—	10	

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Symbol	Parameter	Condition		Limits			Unit
				Min.	Typ.	Max.	
VCE(sat)	Collector-Emitter Saturation Voltage	VD = 15V, IC = 15A VCIN = 0V, Pulsed (Fig. 1)	Tj = 25°C Tj = 125°C	— —	1.8 1.9	2.3 2.4	V
	VFM	FWDi Forward Voltage	IF = 15A (Fig. 2)	—	2.5	3.5	
ICES	Collector-Emitter Cutoff Current	VCE = VCES, VCIN = 15V (Fig. 5)	Tj = 25°C Tj = 125°C	— —	— —	1 10	mA

CONTROL PART

Symbol	Parameter	Condition		Limits			Unit
				Min.	Typ.	Max.	
Id	Circuit Current	VD = 15V, Vcin = 15V	VN1-VNC	—	20	30	mA
			VXP1-VXPC	—	5	10	
Vth(ON)	Input ON Threshold Voltage	Applied between : UP-VUPC, VP-VVPC, WP-VWPC UN • VN • WN • Br-VNC		1.2	1.5	1.8	V
Vth(OFF)	Input OFF Threshold Voltage			1.7	2.0	2.3	
SC	Short Circuit Trip Level	−20 ≤ Tj ≤ 125°C, VD = 15V (Fig. 3,6)	Inverter part	50	—	—	A
			Brake part	30	—	—	
toff(SC)	Short Circuit Current Delay Time	VD = 15V (Fig. 3,6)		—	0.2	—	μs
OT	Over Temperature Protection	Detect Tj of IGBT chip	Trip level	135	145	155	°C
OTr			Reset level	—	125	—	
UV	Supply Circuit Under-Voltage Protection	−20 ≤ Tj ≤ 125°C	Trip level	11.5	12.0	12.5	V
UVr			Reset level	—	12.5	—	
Ifo(H)	Fault Output Current	VD = 15V, Vcin = 15V (Note-3)		—	—	0.01	mA
Ifo(L)				—	10	15	
tFO	Minimum Fault Output Pulse Width	VD = 15V (Note-3)		1.0	1.8	—	ms

(Note-3) Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

MECHANICAL RATINGS AND CHARACTERISTICS

Symbol	Parameter	Condition	Limits			Unit
			Min.	Typ.	Max.	
—	Mounting torque	Mounting part screw : M5	2.5	3.0	3.5	N • m
—	Mounting torque	Mounting part screw : M5	2.5	3.0	3.5	N • m
—	Weight	—	—	380	—	g

RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Condition	Recommended value	Unit
V _{CC}	Supply Voltage	Applied across P-N terminals	≤ 800	V
V _D	Control Supply Voltage	Applied between : VUP1-VUPC, VVP1-VVPC VWP1-VWPC, VN1-VNC (Note-4)	15.0 ± 1.5	V
V _{CIN(ON)}	Input ON Voltage	Applied between : UP-VUPC, VP-VVPC, WP-VWPC UN • VN • WN • Br-VNC	≤ 0.8	V
V _{CIN(OFF)}	Input OFF Voltage		≥ 9.0	
f _{PWM}	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t _{dead}	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig. 7)	≥ 2.5	μs

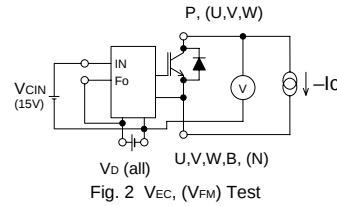
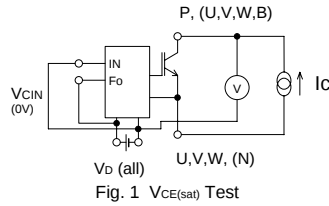
(Note-4) With ripple satisfying the following conditions dv/dt swing ≤ ±5V/μs, Variation ≤ 2V peak to peak

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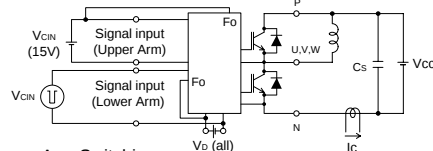
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PRECAUTIONS FOR TESTING

- Before applying any control supply voltage (V_D), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
After this, the specified ON and OFF level setting for each input signal should be done.
- When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V_{CES} rating of the device.
(These test should not be done by using a curve tracer or its equivalent.)



a) Lower Arm Switching



b) Upper Arm Switching

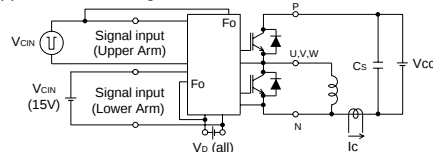


Fig. 3 Switching time and SC test circuit

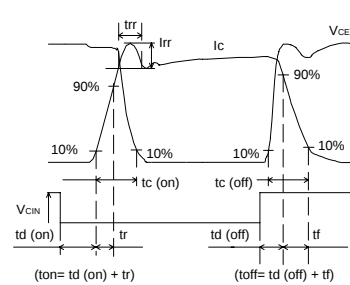


Fig. 4 Switching time test waveform

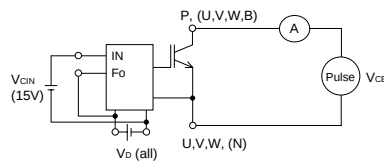


Fig. 5 I_{CES} Test

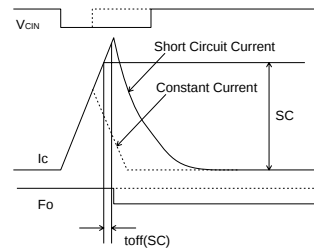
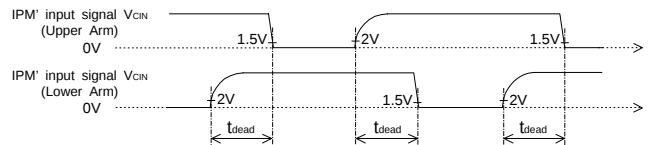


Fig. 6 SC test waveform



1.5V: Input on threshold voltage $V_{th(on)}$ typical value, 2V: Input off threshold voltage $V_{th(off)}$ typical value

Fig. 7 Dead time measurement point example

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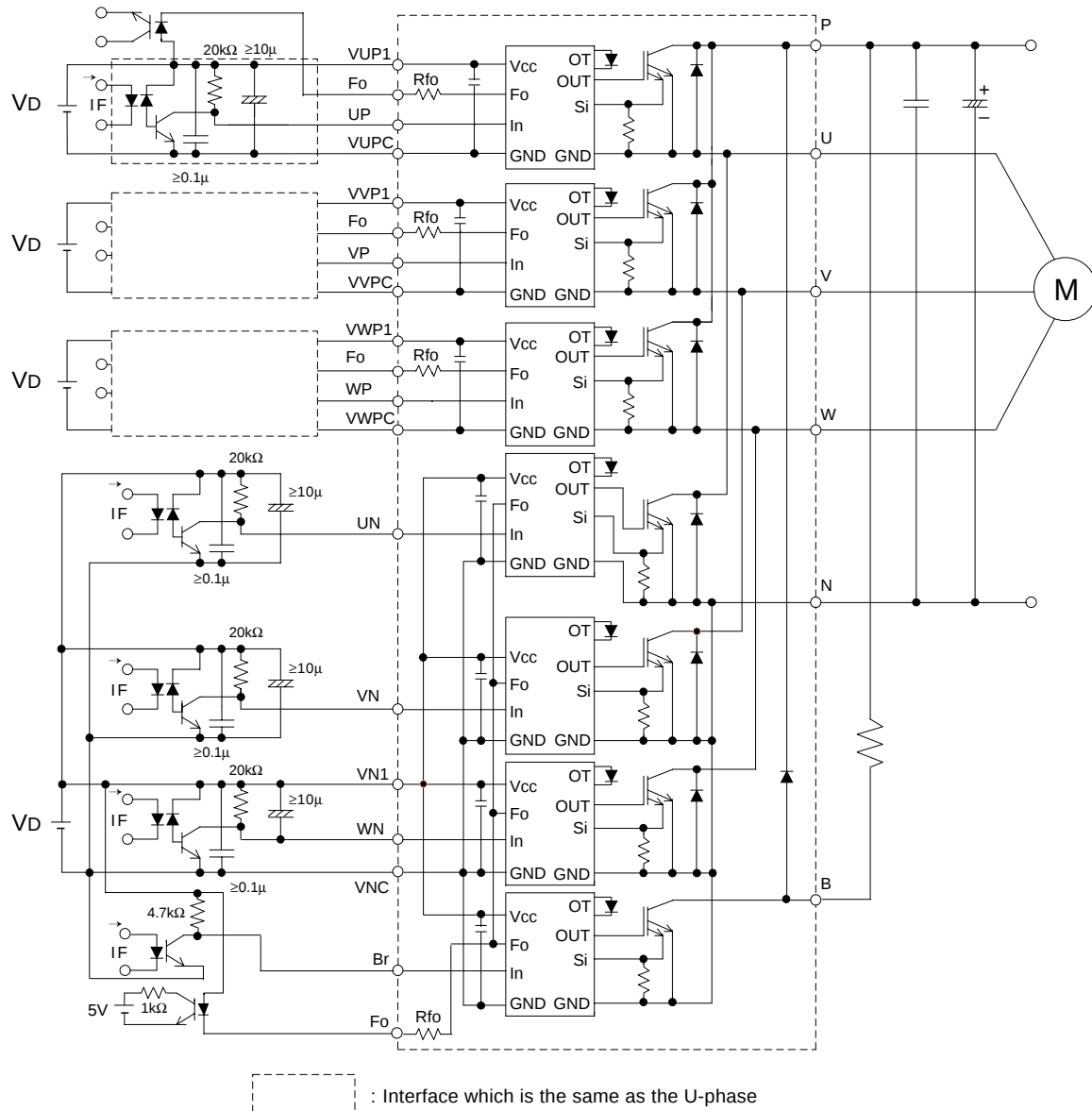


Fig. 8 Application Example Circuit

NOTES FOR STABLE AND SAFE OPERATION ;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers: t_{PLH} , $t_{PHL} \leq 0.8\mu s$, Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- Use 4 isolated control power supplies (VD). Also, care should be taken to minimize the instantaneous voltage charge of the power supply.
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.
- Use line noise filter capacitor (ex. 4.7nF) between each input AC line and ground to reject common-mode noise from AC line and improve noise immunity of the system.